

<b>Notice of References Cited</b>		Application/Control No. 10/002,356	Applicant(s)/Patent Under Reexamination SEAMAN ET AL.	
		Examiner Ba Huynh	Art Unit 2179	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0268224 A1	12-2004	Balkus et al.	715/500.1
*	B	US-2005/0273789 A1	12-2005	Miller et al.	719/310
*	C	US-6,686,918 B1	02-2004	Cajolet et al.	345/473
*	D	US-2001/0040592	11-2001	Foreman et al.	345/723
*	E	US-6,449,653 B2	09-2002	Klemets et al.	709/231
*	F	US-2002/0147834 A1	10-2002	Liou et al.	709/236
*	G	US-6,658,194 B1	12-2003	Omori, Shigeru	386/52
*	H	US-2002/0175917 A1	11-2002	Chakravarty et al.	345/473
*	I	US-2004/0100482 A1	05-2004	Cajolet et al.	345/716
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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